

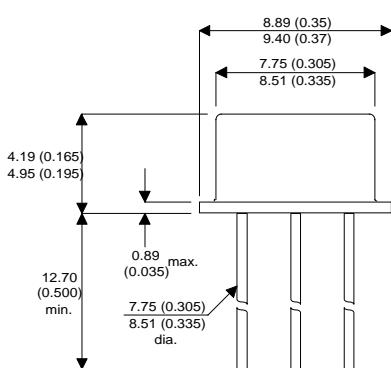


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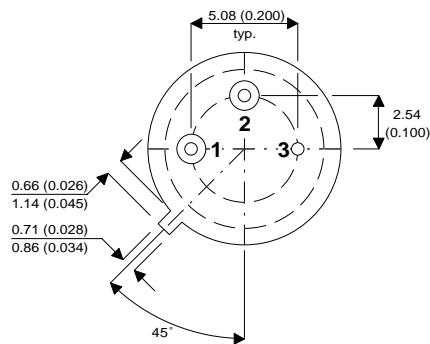
2N6782

MECHANICAL DATA

Dimensions in mm (inches)



N-CHANNEL POWER MOSFET



TO39

Pin 1 - Source

Pin 2 - Gate

Pin 3 Drain and Case

APPLICATIONS

- FAST SWITCHING
- MOTOR CONTROLS
- POWER SUPPLIES

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^\circ\text{C}$ unless otherwise stated)

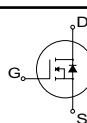
V_{DS}	Drain Source Voltage	100V
GR	Drain Gate Voltage ($R_{GS} = 1\text{M}\Omega$)	100V
$I_D @ T_{case} = 25^\circ\text{C}$	Continuous Drain Current	$\pm 3.5\text{V}$
$I_D @ T_{case} = 100^\circ\text{C}$	Continuous Drain Current	$\pm 2.25\text{A}$
I_{DM}	Pulsed Drain Current ¹	$\pm 8\text{V}$
V_{GS}	Gate Source Voltage	$\pm 40\text{V}$
$P_D @ T_{case} = 25^\circ\text{C}$	Maximum Power Dissipation	15W
$P_D @ T_{case} = 100^\circ\text{C}$	Maximum Power Dissipation	6W
Junction to Case	Linear Derating Factor	$0.12\text{W}/^\circ\text{C}$
Junction to ambient	Linear Derating Factor	$0.005\text{W}/^\circ\text{C}$
T_J, T_{stg}	Operating and Storage Temperature Range	-55 to $+150^\circ\text{C}$
Lead Temperature	(1/16" from case for 10 secs)	300°C



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ELECTRICAL CHARACTERISTICS ($T_{case} = 25^\circ C$ unless otherwise stated)

Parameter	Test Conditions		Min.	Typ.	Max.	Unit
STATIC ELECTRICAL RATINGS						
BV_{DSS}	Drain – Source Breakdown Voltage	$V_{GS} = 0$	$I_D = 0.25mA$	100*		V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$	$I_D = 0.5A$	2*	4.0*	V
			$T_A = 125^\circ C$	1*	4.0*	
I_{GSSF}	Gate Body Leakage Forward	$V_{GS} = 20V$	$I_D = 0.5A$		100*	nA
			$T_A = 125^\circ C$		200*	
I_{GSSR}	Gate Body Leakage Reverse	$V_{GS} = -20V$			-100*	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 0.8 \text{ Max.}$	Ratings $V_{GS} = 0$		0.25*	mA
		$V_{DS} = \text{Max.}$	Ratings $V_{GS} = 0$		1*	
			$T_C = 125^\circ C$			
$I_{D(on)}$	On State Drain Current1	$V_{DS} \geq 2V_{DS(ON)}$	$V_{GS} = 10V$	3.5		A
$V_{DS(on)}$	Static Drain Source On-State Voltage1	$V_{GS} = 10V$	$I_D = 3.5A$	2.1*		V
$R_{DS(on)}$	Static Drain Source On-State Resistance1	$V_{GS} = 10V$	$I_D = 2.25A$		0.6*	Ω
			$T_C = 125^\circ C$		1.08*	
DYNAMIC CHARACTERISTICS						
g_{fs}	Forward Transductance 1	$V_{DS} \geq 2V_{DS(ON)}$	$I_{DS} = 2.25A$	1.0*	3.0*	S (Ω)
C_{iss}	Input Capacitance	$V_{GS} = 0$	$V_{DS} = 25V$	60*	200*	pF
C_{oss}	Output Capacitance	$f = 1MHz$		40*	100*	
C_{rss}	Reverse Transfer Capacitance			10*	25*	
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 34V$	$I_D = 2.25A$		15*	ns
t_r	Rise Time	$R_G = 25\Omega$	$R_L = 15\Omega$		25*	
$t_{d(off)}$	Turn-Off Delay Time	(MOSFET switching times are essentially independent of operating temperature.)			25*	
t_f	Fall Time				20*	
BODY– DRAIN DIODE RATINGS & CHARACTERISTICS						
I_S	Continuous Source Current Body Diode	MODIFIED MOS POWER symbol showing the integral P-N junction rectifier.			-3.5*	A
I_{SM}	Source Current1 (Body Diode)				-8	A
V_{SD}	Diode Forward Voltage 1	$I_S = -3.5A$	$V_{GS} = 0$	-0.75*	-1.5*	V
T_{C}		$T_C = 25^\circ C$				
t_{rr}	Reverse Recovery Time	$I_F = I_S$	$T_J = 150^\circ C$		200	V
		$d_i / d_t = 100A/\mu s$				
THERMAL CHARACTERISTICS						
$R_{\theta JC}$	Thermal Resistance Junction – Case	Free Air Operation			8.33*	°C/W
$R_{\theta JPC}$	Thermal Resistance Junction – PC Board				170	

Notes

1) Pulse Test: Pulse Width $\leq 300\mu s$, $\delta \leq 2\%$

* JEDEC registered Values